TECHNOLOGY CENTER 2800 IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: 2829 Examiner: J. Hollington

In Re NEW PATENT APPLICATION Of:

Applicant:

Mikio OHTAKI

Appln. No.: 09/904,663

Filed:

July 16, 2001

For:

SEMICONDUCTOR DEVICE

TEST METHOD

Atty Ref.:

KAN 120D1

PETITION FOR EXTENSION OF TIME

September 17, 2002

Commissioner for Patents Washington, D.C. 20231

Sir:

It is respectfully requested that the period for replying to the Examiner's Action dated April 17, 2002, be extended for two months under the provisions of 37 C.F.R. § 1.136(b). The applicable extension fee of \$400.00, under the provisions of 37 C.F.R. §1.17(a) is submitted herewith. Should any additional fees be required please charge the same to our Deposit Account No. 18-0002 and advise us accordingly.

Respectfully submitted,

<u>September 17, 2002</u>

Date

Steven M. Rabin - Reg. No. 29,102

RABIN & BERDO, P.C.

Telephone: 202-659-1915

Telefax:

202-659-1898

CUSTOMER NO. 23995

SMR:pil

09/26/2002 AWONDAF1 00000014 09904663

01 FC:116

400.00 OP

BEST AVAILABLE COPY